Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | OHKAWA ET AL. | Examiner | Art Unit | Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,902,638	05-1999	Vakil, Himanshu Bachubhai	427/248.1
	В	US-6,395,381	05-2002	Kondo et al.	428/317.9
	O	US-5,512,540	04-1996	Yamazaki, Shunpei	505/325
	D	US-			
	Ш	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ	,				
	σ					
	R			**		
	s	·				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U.	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.